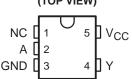
SCES296N - FEBRUARY 2000 - REVISED SEPTEMBER 2003

- Available in the Texas Instruments NanoStar<sup>™</sup> and NanoFree<sup>™</sup> Packages
- Supports 5-V V<sub>CC</sub> Operation
- Input and Open-Drain Output Accept Voltages Up To 5.5 V
- Max t<sub>pd</sub> of 4.2 ns at 3.3 V
- Low Power Consumption, 10-μA Max I<sub>CC</sub>
- ±24-mA Output Drive at 3.3 V
- I<sub>off</sub> Supports Partial-Power-Down Mode Operation
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Protection Exceeds JESD 22

   2000-V Human-Body Model (A114-A)
  - 200-V Machine Model (A115-A)
  - 1000-V Charged-Device Model (C101)

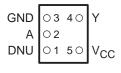
#### description/ordering information





NC – No internal connection

YEA, YEP, YZA, OR YZP PACKAGE (BOTTOM VIEW)



DNU - Do not use

This single buffer/driver is designed for 1.65-V to 5.5-V  $V_{CC}$  operation.

NanoStar™ and NanoFree™ package technology is a major breakthrough in IC packaging concepts, using the die as the package.

The output of the SN74LVC1G07 device is open drain and can be connected to other open-drain outputs to implement active-low wired-OR or active-high wired-AND functions. The maximum sink current is 32 mA.

TA	PACKAGE <sup>†</sup>	ORDERABLE PART NUMBER	TOP-SIDE MARKING <sup>‡</sup>		
	NanoStar™ – WCSP (DSBGA) 0.17-mm Small Bump – YEA		SN74LVC1G07YEAR		
	NanoFree™ – WCSP (DSBGA) 0.17-mm Small Bump – YZA (Pb-free)	Deal of 2000	SN74LVC1G07YZAR	0.1	
	NanoStar™ – WCSP (DSBGA) 0.23-mm Large Bump – YEP	Reel of 3000	SN74LVC1G07YEPR	CV_	
–40°C to 85°C	NanoFree™ – WCSP (DSBGA) 0.23-mm Large Bump – YZP (Pb-free)		SN74LVC1G07YZPR		
	SOT (SOT-23) – DBV	Reel of 3000	SN74LVC1G07DBVR	007	
	301 (301-23) - DBV	Reel of 250	SN74LVC1G07DBVT	C07_	
	SOT (SC-70) – DCK	Reel of 3000	SN74LVC1G07DCKR	CV	
	501 (50-70) - DOK	Reel of 250	SN74LVC1G07DCKT		

#### **ORDERING INFORMATION**

<sup>†</sup> Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

DBV/DCK: The actual top-side marking has one additional character that designates the assembly/test site. YEA/YZA,YEP/YZP: The actual top-side marking has three preceding characters to denote year, month, and sequence code, and one following character to designate the assembly/test site. Pin 1 identifier indicates solder-bump composition (1 = SnPb, • = Pb-free).



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

NanoStar and NanoFree are trademarks of Texas Instruments.

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



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## description/ordering information (continued)

This device is fully specified for partial-power-down applications using  $I_{off}$ . The  $I_{off}$  circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

FUNCTION TABLE					
INPUT	OUTPUT				
A	Y				
Н	н				
L	L				

#### logic diagram (positive logic)



#### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

Voltage range applied to any output in the high	
(see Notes 1 and 2)	-0.5 V to 6.5 V
Input clamp current, I <sub>IK</sub> (V <sub>I</sub> < 0)	
	±50 mA
	±100 mA
	: DBV package 206°C/W
	DCK package 252°C/W
	YEA/YZA package 154°C/W
	YEP/YZP package 132°C/W
Storage temperature range, T <sub>stg</sub>	

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.
  - 2. The value of  $V_{CC}$  is provided in the recommended operating conditions table.
  - 3. The package thermal impedance is calculated in accordance with JESD 51-7.



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#### recommended operating conditions (see Note 4)

			MIN	MAX	UNIT	
Vaa	Operating		1.65	5.5	V	
Vcc	Supply voltage	Data retention only	1.5		v	
		V <sub>CC</sub> = 1.65 V to 1.95 V	$0.65 \times V_{CC}$			
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	1.7		V	
VIH	High-level input voltage	$V_{CC} = 3 V \text{ to } 3.6 V$	2		v	
		$V_{CC} = 4.5 V \text{ to } 5.5 V$	$0.7 \times V_{CC}$			
		V <sub>CC</sub> = 1.65 V to 1.95 V		$0.35 \times V_{CC}$		
Ma		V <sub>CC</sub> = 2.3 V to 2.7 V		0.7	V	
VIL	Low-level input voltage $\frac{V_{CC} = 3 \text{ V to } 3.6 \text{ V}}{V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}}$	$V_{CC} = 3 V \text{ to } 3.6 V$		0.8	v	
		$V_{CC} = 4.5 V \text{ to } 5.5 V$		$0.3 \times V_{CC}$	1	
VI	Input voltage		0	5.5	V	
Vo	Output voltage		0	5.5	V	
		V <sub>CC</sub> = 1.65 V		4		
		V <sub>CC</sub> = 2.3 V		8	mA	
IOL	Low-level output current			16		
		V <sub>CC</sub> = 3 V		24		
		$V_{CC} = 4.5 V$		32		
		$V_{CC}$ = 1.8 V ± 0.15 V, 2.5 V ± 0.2 V		20		
$\Delta t / \Delta v$	Input transition rise or fall rate	$V_{CC} = 3.3 V \pm 0.3 V$	10			
		$V_{CC}$ = 5 V ± 0.5 V				
TA	Operating free-air temperature	÷	-40	85	°C	

NOTE 4: All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	V <sub>CC</sub>	ΜΙΝ ΤΥΡΤ ΜΑΧ	UNIT	
		I <sub>OL</sub> = 100 μA	1.65 V to 5.5 V	0.1		
		I <sub>OL</sub> = 4 mA	1.65 V	0.45		
		I <sub>OL</sub> = 8 mA	2.3 V	0.3		
VOL		I <sub>OL</sub> = 16 mA	0.14	0.4	V	
		I <sub>OL</sub> = 24 mA	3 V	0.55		
		I <sub>OL</sub> = 32 mA	4.5 V	0.55		
lj	A input	$V_{I} = 5.5 V \text{ or GND}$	0 to 5.5 V	±5	μA	
l <sub>off</sub>		$V_{I} \text{ or } V_{O} = 5.5 \text{ V}$	0	±10	μΑ	
ICC		$V_{I} = 5.5 \text{ V or GND}, \qquad I_{O} = 0$	1.65 V to 5.5 V	10	μΑ	
ΔICC		One input at $V_{CC} - 0.6 V$ , Other inputs at $V_{CC}$ or GND	3 V to 5.5 V	500	μA	
Ci		$V_{I} = V_{CC} \text{ or } GND$	3.3 V	4	pF	
$C_0$ $V_0 = V_{CC}$ or GND		$V_{O} = V_{CC} \text{ or } GND$	3.3 V	5	pF	

<sup>†</sup> All typical values are at  $V_{CC} = 3.3 \text{ V}$ ,  $T_A = 25^{\circ}C$ .



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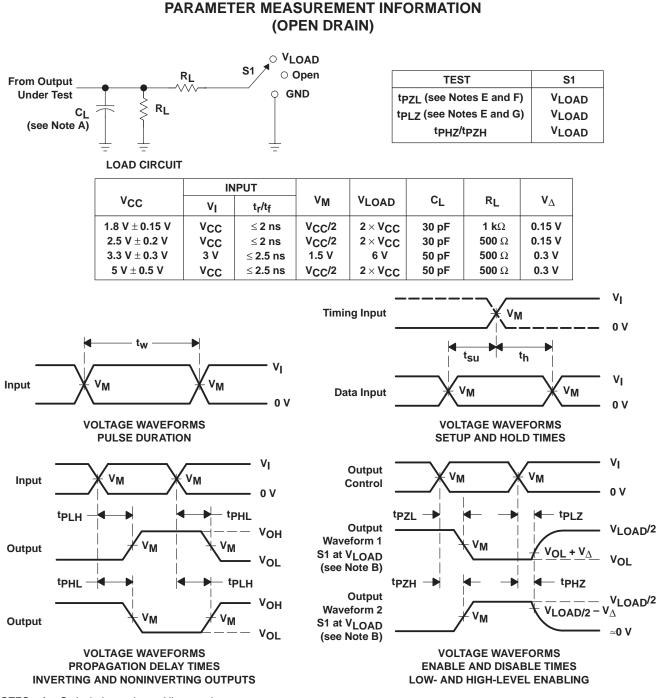
# switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>CC</sub> = ± 0.1		V <sub>CC</sub> = ± 0.		= ۷ <sub>CC</sub> ± 0.3		= V <sub>CC</sub> ± 0.		UNIT
		MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX		
<sup>t</sup> pd	A	Y	2.4	8.3	1	5.5	1.5	4.2	1	3.5	ns

### operating characteristics, $T_A = 25^{\circ}C$

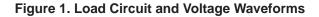
PARAMETER		TEST CONDITIONS	V <sub>CC</sub> = 1.8 V V <sub>CC</sub> = 2.5 V		V <sub>CC</sub> = 3.3 V V <sub>CC</sub> = 5 V		UNIT
		TEST CONDITIONS	TYP	TYP	TYP	ТҮР	UNIT
C <sub>pd</sub> I	Power dissipation capacitance	f = 10 MHz	3	3	4	6	pF





NOTES: A. CL includes probe and jig capacitance.

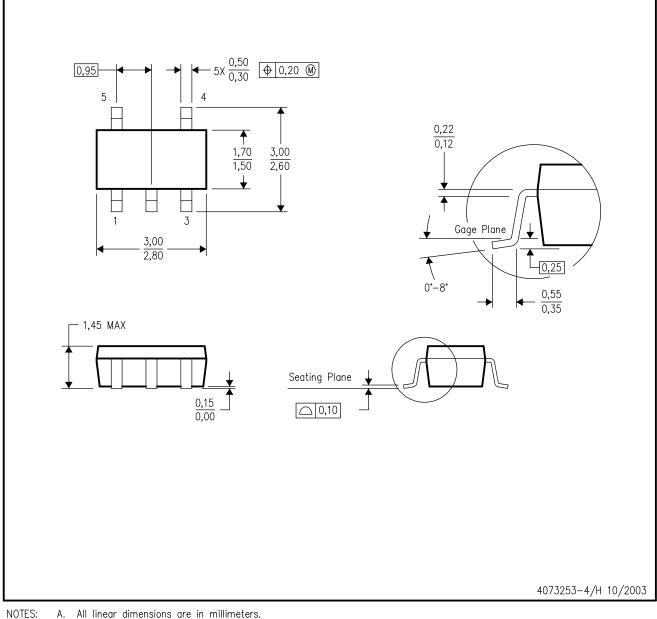
- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, Z<sub>O</sub> = 50  $\Omega$ .
- D. The outputs are measured one at a time with one transition per measurement.
- E. Since this device has open-drain outputs, tPLZ and tPZL are the same as tpd.
- F.  $t_{PZL}$  is measured at  $V_{M}$ .
- G. tpLZ is measured at VOL + V $_{\Delta}$ .
- H. All parameters and waveforms are not applicable to all devices.





DBV (R-PDSO-G5)

PLASTIC SMALL-OUTLINE PACKAGE



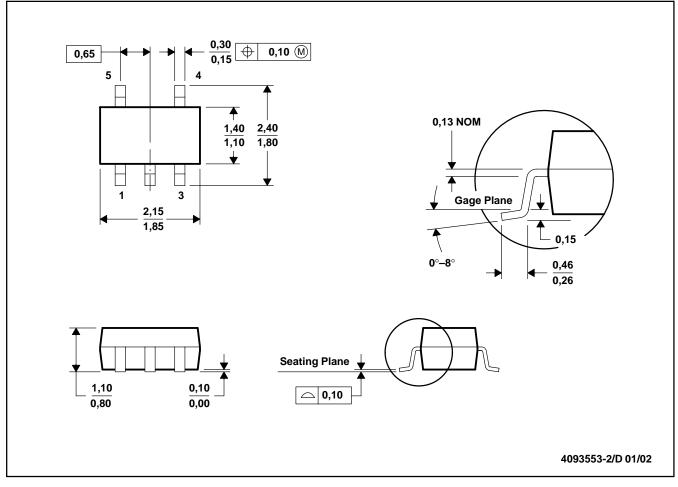
- Α. All linear dimensions are in millimeters.
  - Β. This drawing is subject to change without notice.
  - C. Body dimensions do not include mold fla D. Falls within JEDEC MO-178 Variation AA. Body dimensions do not include mold flash or protrusion.



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#### DCK (R-PDSO-G5)

PLASTIC SMALL-OUTLINE PACKAGE



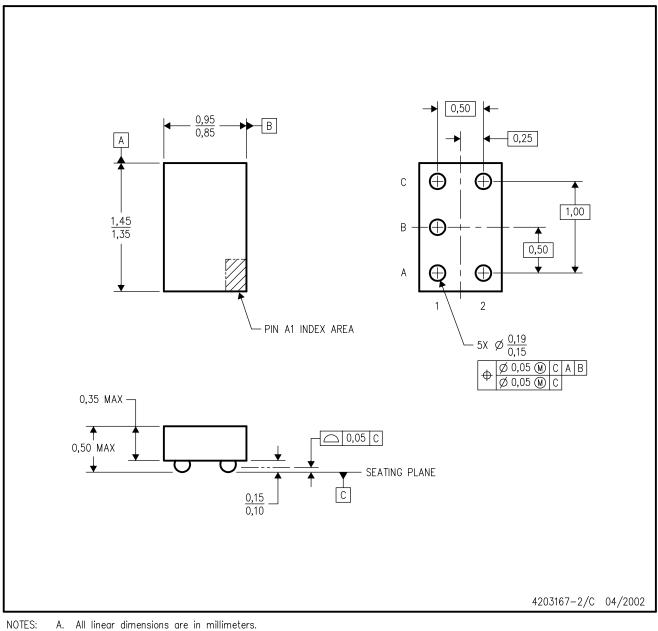
NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion.
- D. Falls within JEDEC MO-203



YEA (R-XBGA-N5)

DIE-SIZE BALL GRID ARRAY



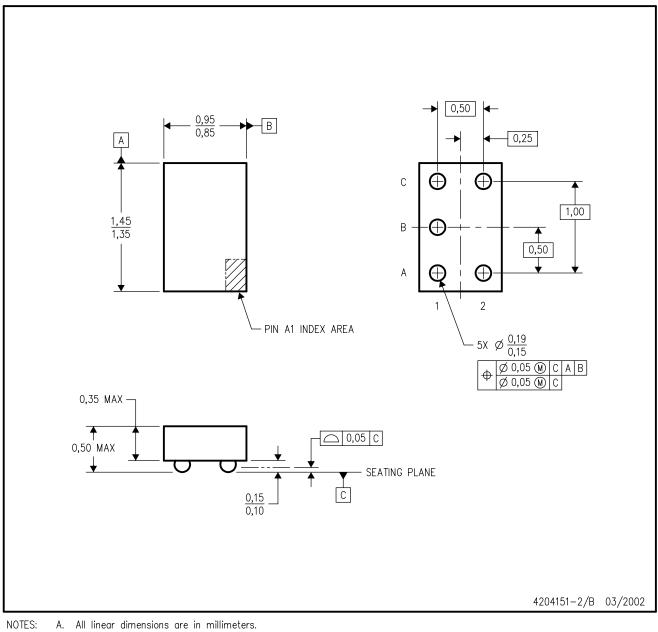
- B. This drawing is subject to change without notice.
- C. NanoStar™ package configuration.
- D. Package complies to JEDEC MO-211 variation EA.
- E. This package is tin-lead (SnPb). Refer to the 5 YZA package (drawing 4204151) for lead-free.

NanoStar is a trademark of Texas Instruments.



YZA (R-XBGA-N5)

DIE-SIZE BALL GRID ARRAY



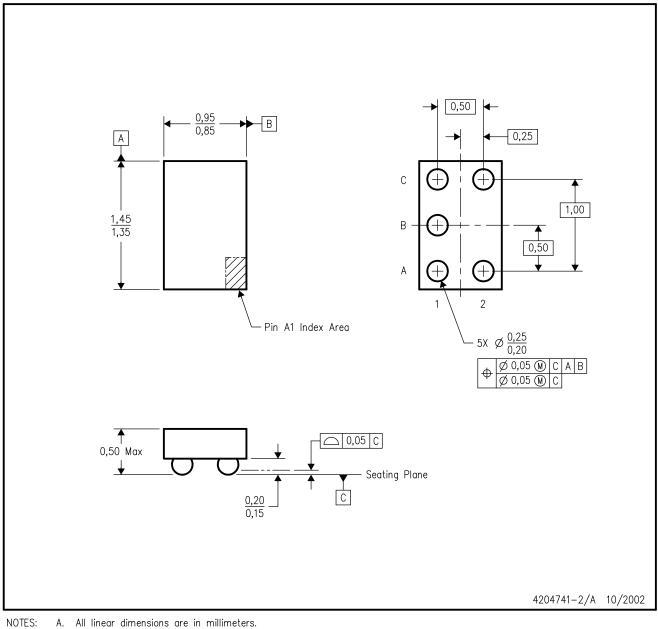
- B. This drawing is subject to change without notice.
- C. NanoFree™ package configuration.
- D. Package complies to JEDEC MO-211 variation EA.
- E. This package is lead-free. Refer to the 5 YEA package (drawing 4203167) for tin-lead (SnPb).

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YZP (R-XBGA-N5)

DIE-SIZE BALL GRID ARRAY



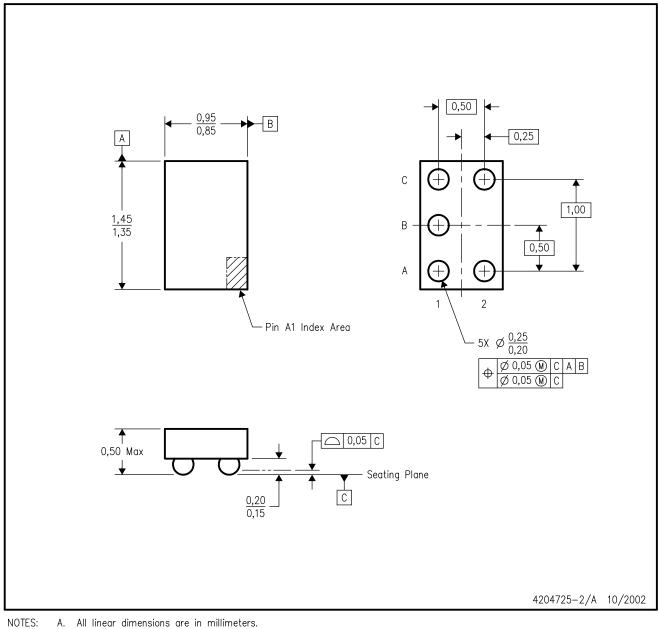
- B. This drawing is subject to change without notice.
- C. NanoFree™ package configuration.
- D. This package is lead-free. Refer to the 5 YEP package (drawing 4204725) for tin-lead (SnPb).

NanoFree is a trademark of Texas Instruments.



YEP (R-XBGA-N5)

DIE-SIZE BALL GRID ARRAY



- B. This drawing is subject to change without notice.
- C. NanoStar™ package configuration.
- D. This package is tin-lead (SnPb). Refer to the 5 YZP package (drawing 4204741) for lead-free.

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